

# SEMiX453GD176HDc



SEMiX<sup>®</sup> 33c

## Trench IGBT Modules

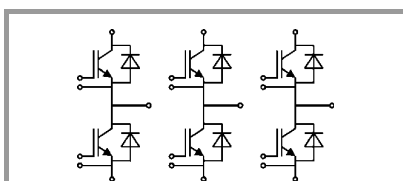
### SEMiX453GD176HDc

#### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- UL recognised file no. E63532

#### Typical Applications\*

- AC inverter drives
- UPS
- Electronic welders



GD

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
<b>IGBT</b>				
$V_{CES}$			1700	V
$I_C$	$T_j = 150\text{ °C}$	$T_c = 25\text{ °C}$	444	A
		$T_c = 80\text{ °C}$	315	A
$I_{Cnom}$			300	A
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$		600	A
$V_{GES}$			-20 ... 20	V
$t_{psc}$	$V_{CC} = 1000\text{ V}$ $V_{GE} \leq 20\text{ V}$ $V_{CES} \leq 1700\text{ V}$	$T_j = 125\text{ °C}$	10	$\mu\text{s}$
$T_j$			-55 ... 150	$^{\circ}\text{C}$
<b>Inverse diode</b>				
$I_F$	$T_j = 150\text{ °C}$	$T_c = 25\text{ °C}$	545	A
		$T_c = 80\text{ °C}$	365	A
$I_{Fnom}$			300	A
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$		600	A
$I_{FSM}$	$t_p = 10\text{ ms}$ , $\sin 180^{\circ}$ , $T_j = 25\text{ °C}$		2900	A
$T_j$			-40 ... 150	$^{\circ}\text{C}$
<b>Module</b>				
$I_{t(RMS)}$			600	A
$T_{stg}$			-40 ... 125	$^{\circ}\text{C}$
$V_{isol}$	AC sinus 50Hz, $t = 1\text{ min}$		4000	V

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>IGBT</b>						
$V_{CE(sat)}$	$I_C = 300\text{ A}$ $V_{GE} = 15\text{ V}$ chipllevel	$T_j = 25\text{ °C}$		2	2.45	V
		$T_j = 125\text{ °C}$		2.45	2.9	V
$V_{CE0}$			$T_j = 25\text{ °C}$	1	1.2	V
			$T_j = 125\text{ °C}$	0.9	1.1	V
$r_{CE}$	$V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}$	3.3	4.2		$\text{m}\Omega$
		$T_j = 125\text{ °C}$	5.2	6.0		$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 12\text{ mA}$		5.2	5.8	6.4	V
$I_{CES}$	$V_{GE} = 0\text{ V}$ $V_{CE} = 1700\text{ V}$	$T_j = 25\text{ °C}$			3	mA
		$T_j = 125\text{ °C}$				mA
$C_{ies}$	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$		$f = 1\text{ MHz}$		26.4	nF
$C_{oes}$			$f = 1\text{ MHz}$		1.10	nF
$C_{res}$			$f = 1\text{ MHz}$		0.88	nF
$Q_G$	$V_{GE} = -8\text{ V} \dots +15\text{ V}$			2799		nC
$R_{Gint}$	$T_j = 25\text{ °C}$			2.50		$\Omega$
$t_{d(on)}$	$V_{CC} = 1200\text{ V}$ $I_C = 300\text{ A}$	$T_j = 125\text{ °C}$		335		ns
$t_r$		$T_j = 125\text{ °C}$		70		ns
$E_{on}$	$R_{G\ on} = 4.3\ \Omega$ $R_{G\ off} = 4.3\ \Omega$		$T_j = 125\text{ °C}$		215	mJ
$t_{d(off)}$			$T_j = 125\text{ °C}$		990	ns
$t_f$			$T_j = 125\text{ °C}$		150	ns
$E_{off}$			$T_j = 125\text{ °C}$		125	mJ
$R_{th(j-c)}$			per IGBT			0.071

# SEMiX453GD176HDc



SEMiX<sup>®</sup> 33c

## Trench IGBT Modules

### SEMiX453GD176HDc

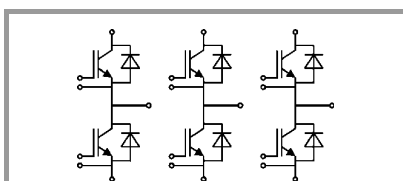
#### Features

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#### Typical Applications\*

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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>Inverse diode</b>						
$V_F = V_{EC}$	$I_F = 300\text{ A}$ $V_{GE} = 0\text{ V}$ chip	$T_j = 25\text{ °C}$		1.5	1.70	V
		$T_j = 125\text{ °C}$		1.4	1.6	V
$V_{F0}$		$T_j = 25\text{ °C}$	0.9	1.1	1.3	V
		$T_j = 125\text{ °C}$	0.7	0.9	1.1	V
$r_F$		$T_j = 25\text{ °C}$	1.3	1.3	1.3	mΩ
		$T_j = 125\text{ °C}$	1.8	1.8	1.8	mΩ
$I_{RRM}$	$I_F = 300\text{ A}$	$T_j = 125\text{ °C}$		350		A
$Q_{rr}$	$di/dt_{off} = 4700\text{ A}/\mu\text{s}$	$T_j = 125\text{ °C}$		115		μC
$E_{rr}$	$V_{GE} = -15\text{ V}$ $V_{CC} = 1200\text{ V}$	$T_j = 125\text{ °C}$		65		mJ
$R_{th(j-c)}$	per diode				0.11	K/W
<b>Module</b>						
$L_{CE}$				20		nH
$R_{CC+EE}$	res., terminal-chip	$T_C = 25\text{ °C}$		0.7		mΩ
		$T_C = 125\text{ °C}$		1		mΩ
$R_{th(c-s)}$	per module			0.014		K/W
$M_s$	to heat sink (M5)		3		5	Nm
$M_t$	to terminals (M6)		2.5		5	Nm
						Nm
w					900	g
<b>Temperatur Sensor</b>						
$R_{100}$	$T_c = 100\text{ °C}$ ( $R_{25} = 5\text{ k}\Omega$ )			$493 \pm 5\%$		Ω
$B_{100/125}$	$R_{(T)} = R_{100} \exp[B_{100/125}(1/T - 1/T_{100})]$ ; $T[\text{K}]$ ;			$3550 \pm 2\%$		K



GD

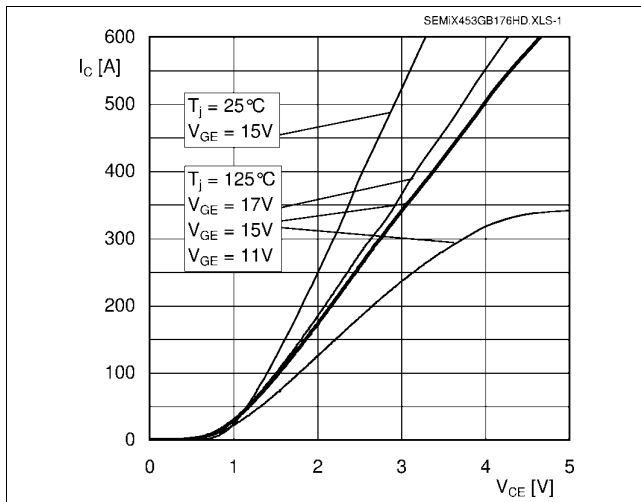


Fig. 1: Typ. output characteristic, inclusive  $R_{CC+EE'}$

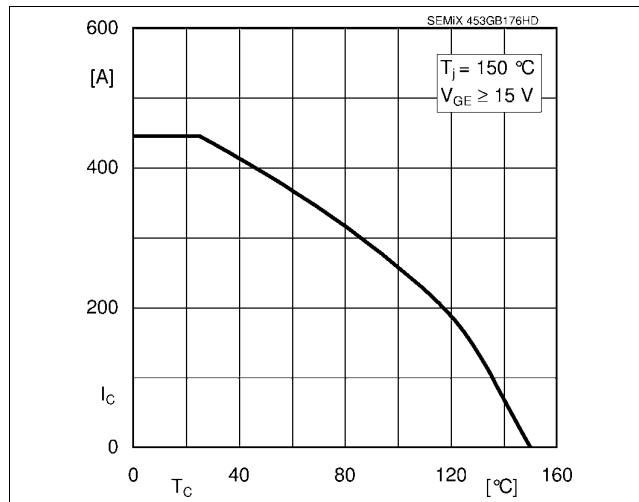


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

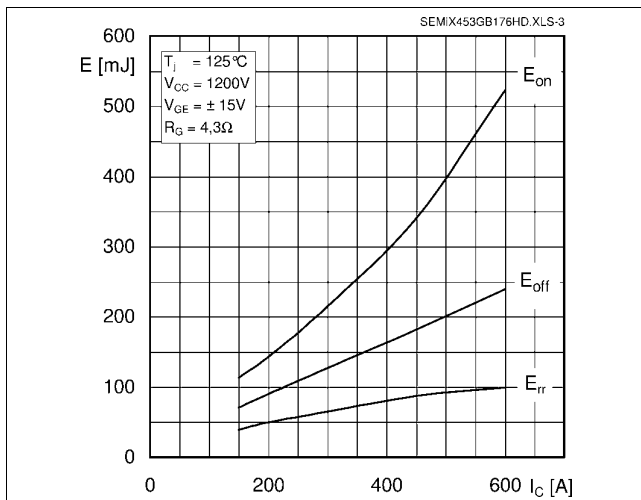


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

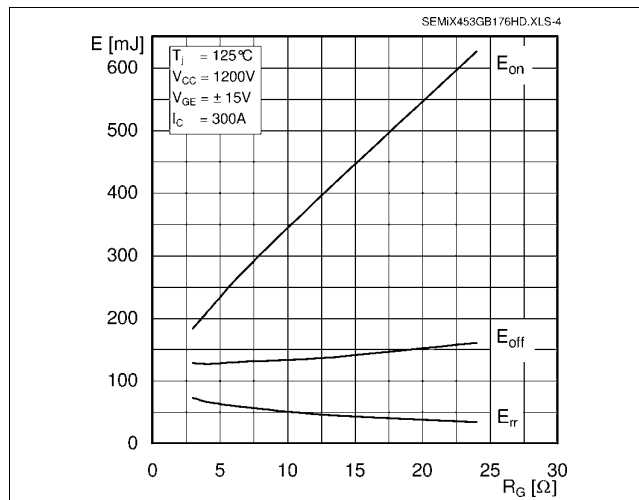


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

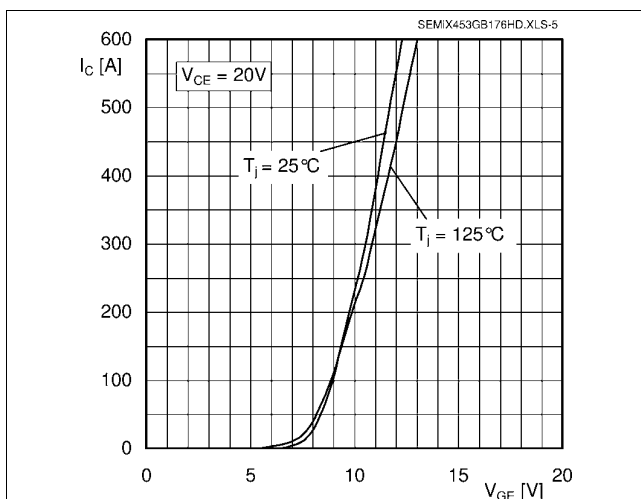


Fig. 5: Typ. transfer characteristic

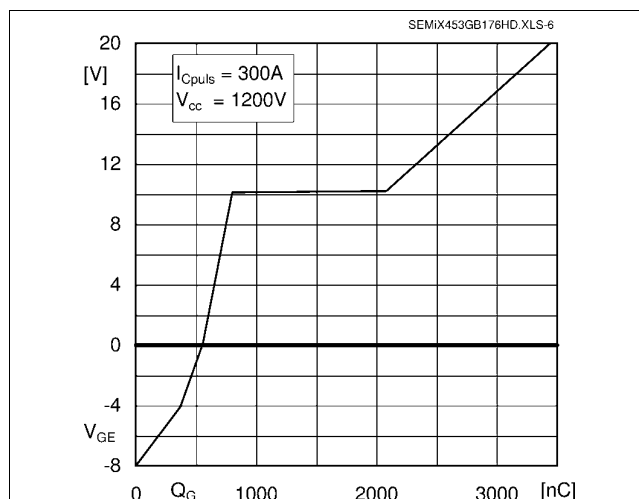


Fig. 6: Typ. gate charge characteristic

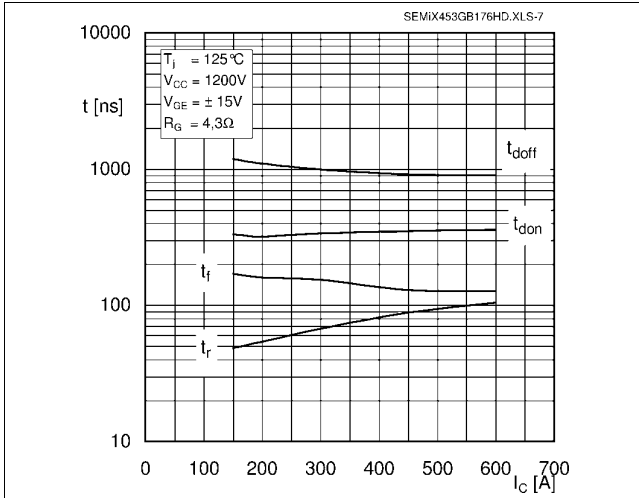


Fig. 7: Typ. switching times vs.  $I_C$

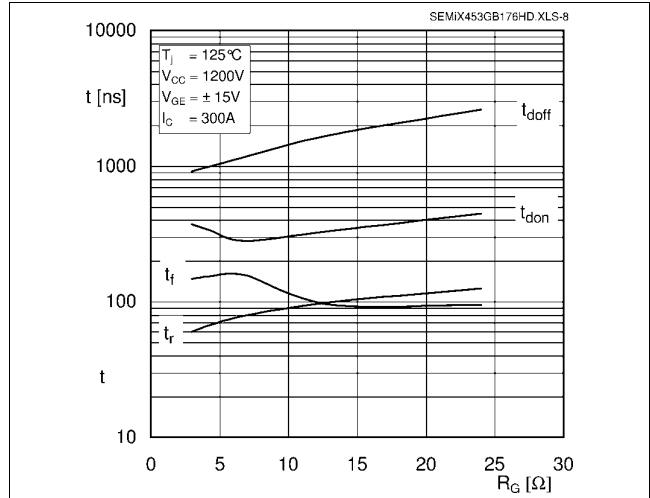


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

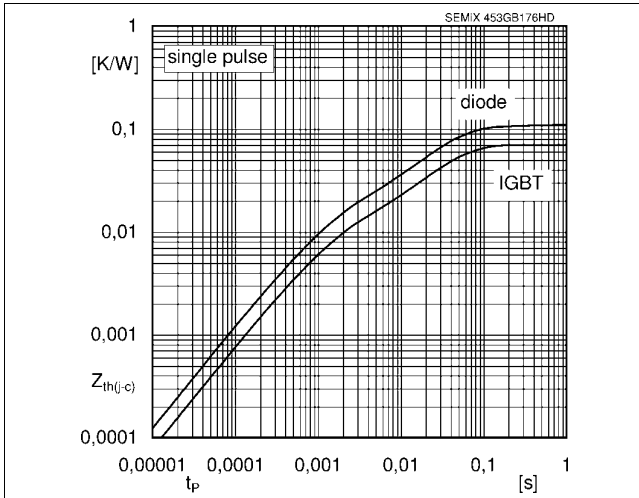


Fig. 9: Typ. transient thermal impedance

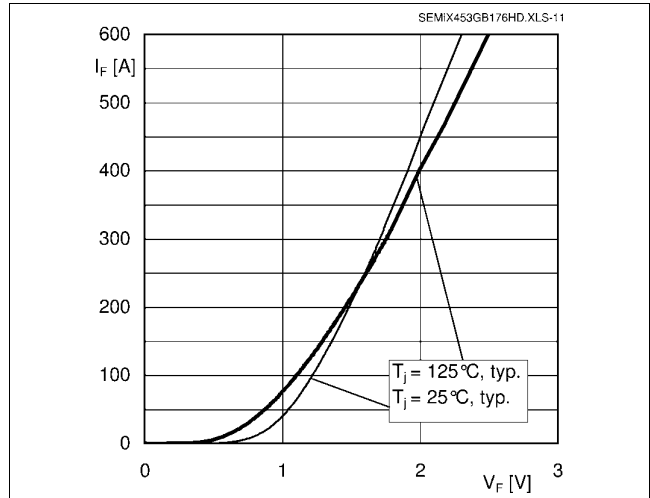


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC'+EE'}$

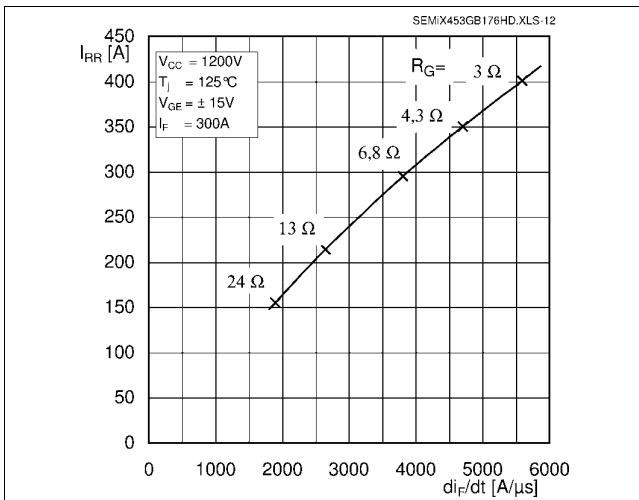


Fig. 11: Typ. CAL diode peak reverse recovery current

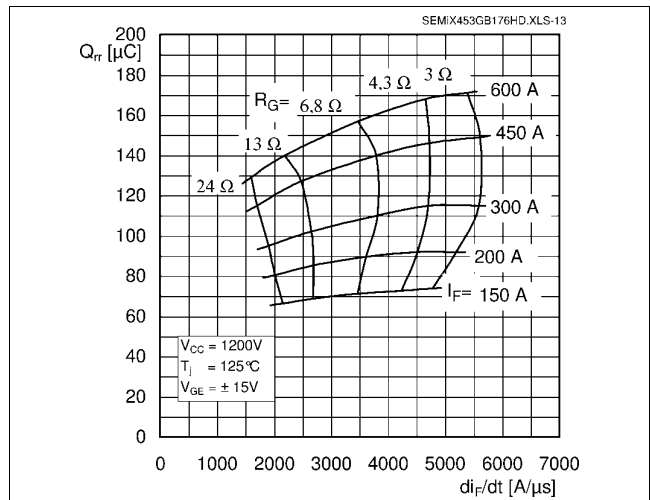
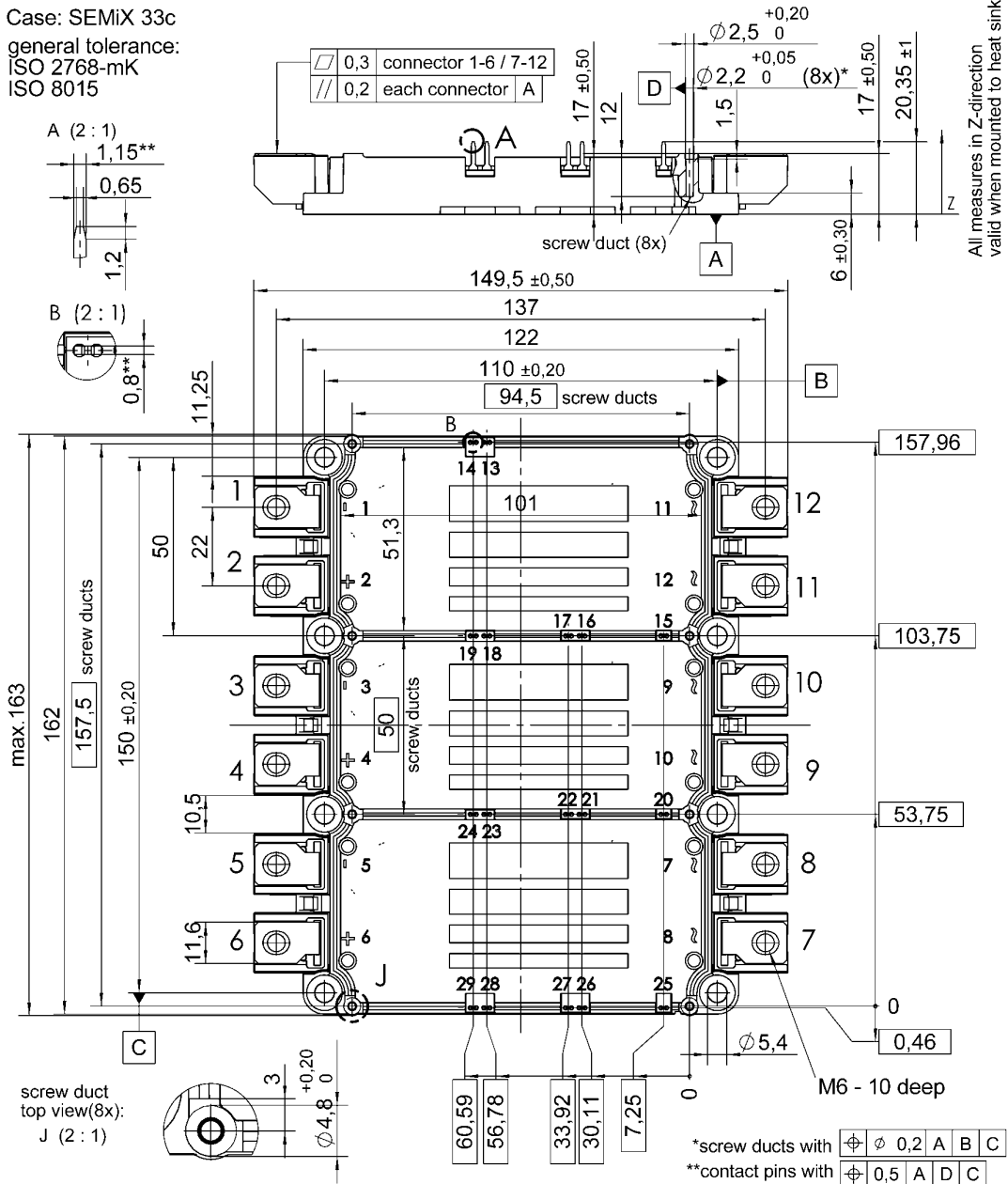


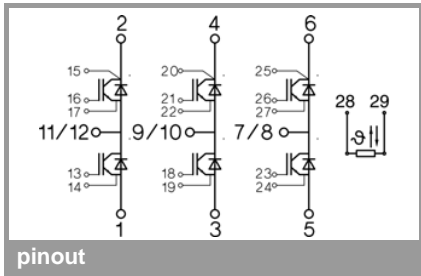
Fig. 12: Typ. CAL diode recovery charge

# SEMiX453GD176HDc

Case: SEMiX 33c  
 general tolerance:  
 ISO 2768-mK  
 ISO 8015



SEMiX 33c



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.